

SOT-23



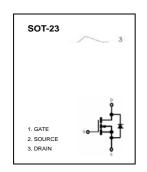


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20V P-Channel MOSFET

General Description

The 3423 uses advanced trench technology to provi de excellent $R_{\rm DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch applications.

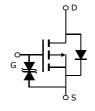


Product Summary

 $\begin{array}{lll} V_{DS} & -20V \\ I_{D} \ (at \ V_{GS} \!\!=\! \!\!\!-10V) & -2A \\ R_{DS(ON)} \ (at \ V_{GS} \!\!=\! \!\!\!\!-10V) & < 92m\Omega \\ R_{DS(ON)} \ (at \ V_{GS} \!\!=\! \!\!\!\!\!-4.5V) & < 118m\Omega \\ R_{DS(ON)} \ (at \ V_{GS} \!\!=\! \!\!\!\!\!\!\!\!-2.5V) & < 166m\Omega \end{array}$

Typical ESD protection

HBM Class 2

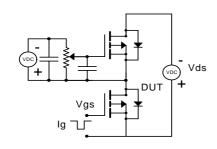


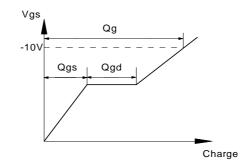
Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units
D		V	-20	V
Gate-Source Voltage		V_{GS}	±12	V
Continuous Drain	T _A =25℃	1	-2	
Current	T _A =70℃	'D	-2	A
Pulsed Drain Current ^C		I _{DM}	-17	
	T _A =25℃	В	1.4	W
Power Dissipation ^B	T _A =70℃	P_{D}	0.9	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C

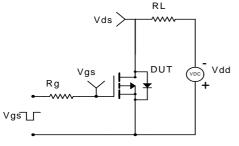
Thermal Characteristics							
Parameter	Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient	t ≤ 10s	D	65	90	€/W		
Maximum Junction-to-Ambient D	Steady-State	$R_{\theta JA}$	85	125	€/W		
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	43	60	C/W		

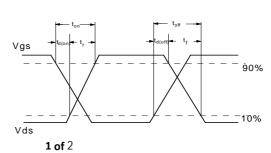
Gate Charge Test Circuit & Waveform





Resistive Switching Test Circuit & Waveforms







<u>SOT-23</u> CB3423





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CB3423 20V P-Channel MOSFET

Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units		
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$		-20			V		
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-20V, V _{GS} =0V				-1	^		
			T _J =55℃			-5	μΑ		
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±12V				±10	μΑ		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=-250\mu A$		-0.5	-0.85	-1.2	V		
I _{D(ON)}	On state drain current	V_{GS} =-4.5V, V_{DS} =-5V		-17			Α		
		V_{GS} =-10V, I_D =-2A			76	92	mΩ		
D	Static Drain Source On Resistance		T _J =125℃		99	119	11122		
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =-4.5V, I_{D} =-2A			94	118	mΩ		
		V_{GS} =-2.5V, I_{D} =-1A			128	166	mΩ		
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-2A			6.8		S		
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V			-0.76	-1	V		
Is	Maximum Body-Diode Continuous Current					-1.5	Α		
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance			250	325	400	pF		
C _{oss}	Output Capacitance	V _{GS} =0V, V _{DS} =-10V, f=1MHz		40	63	85	pF		
C _{rss}	Reverse Transfer Capacitance			22	37	52	pF		
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz			11.2	17	Ω		
SWITCHI	NG PARAMETERS		•						
Q_g	Total Gate Charge				3.2	4.5	nC		
Q_{gs}	Gate Source Charge	V _{GS} =-4.5V, V _{DS} =-10V, I _D =-2A			0.6		nC		
Q_{gd}	Gate Drain Charge				0.9		nC		
t _{D(on)}	Turn-On DelayTime				11		ns		
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-10V, R_L =5 Ω , R_{GEN} =3 Ω			5.5		ns		
t _{D(off)}	Turn-Off DelayTime				22		ns		
t _f	Turn-Off Fall Time	1	ľ		8		ns		
t _{rr}	Body Diode Reverse Recovery Time	I _F =-2A, dI/dt=100A/μs			6.1		ns		
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-2A, dI/dt=100A/μs			1.4		nC		
A. The value	The value of R is measured with the device mounted on Jin² FR-4 hoard with 2oz. Copper in a still air environment with T. =25° C. The								

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leq 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_i=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.